

**Search Notes**

Application/Control No.

10/776,962

Examiner

Than Nguyen

Applicant(s)/Patent under  
Reexamination

MIZUSHIMA ET AL.

Art Unit

2187

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST Inventor IEEE	8/23/2006	NTV